

<b>Notice of References Cited</b>	Application/Control No. 10/634,516	Applicant(s)/Patent Under Reexamination MITCHELL ET AL.	
	Examiner Brian J. Davis	Art Unit 1621	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-4,153,581	05-1979	Habermann, Clarence E.	502/329
	B	US-4,480,131	10-1984	Klier et al.	564/480
	C	US-4,642,381	02-1987	Klier et al.	564/480
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Database CAPLUS on STN, Acc. No. 1995:848208, SHUIKIN et al., Izvestiya Akademii Nauk, Seriya Khimicheskaya (1993), Vo. 4, p. 799-800 (abstract).
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.